

Date:	March 31, 2009	
Applicant:	Novatel Wireless Inc. 9645 Scranton Rd, Suite 205 San Diego, CA 92121	
Attention of:	John Spall, Project Manager Ph: 858-812-0697 Fax: 858-450-7183 email: jspall@nvtl.com	
Equipment: FCC ID: FCC Rules:	PKRNVWE760D co located with E2K533ANH PKRNVWE760D Radio Frequency Radiation Exposure Limits 47 CFR 1.1310 MPE - Mobiles <u>X</u>	Fixed Based Station

Gentlemen:

Enclosed please find your copy of the Supplemental Test Data Report, the whole for Environmental Assessment (MPE) of the referenced equipment as shown.

Please allow from 8-12 weeks to hear from the Commission, who may request additional data or information, and even a sample for pre-grant audit testing.

Should you need any clarification, just fax or phone. Thank you again for this order - it has been a pleasure to be of service.

Hoosamuddin S. Bandukwala, Lab Director

Supervised By:

Flom Test Labs 3356 N. San Marcos Place, Suite 107 Chandler, Arizona 85225-7176 (866) 311-3268 phone, (480) 926-3598



Date:

March 31, 2009

Federal Communications Commission Via: Electronic Filing

Attention:	Authorization & Evaluation Division	
Applicant: Equipment: FCC ID: FCC Rules:	Novatel Wireless Inc. PKRNVWE760D co located with E2K533ANH PKRNVWE760D Radio Frequency Radiation Exposure Limits 47 CFR 1.1310 MPE - Mobiles <u>X</u>	Fixed Based Station

Gentlemen:

On behalf of the Applicant, enclosed please find the Supplemental Test Data Report, the whole for Environmental Assessment (MPE) of the referenced equipment as shown.

We trust the same is in order. Should you need any further information, kindly contact the writer who is authorized to act as agent.

Jude

Hoosamuddin S. Bandukwala, Lab Director

Supervised By:

Flom Test Labs 3356 N. San Marcos Place, Suite 107 Chandler, Arizona 85225-7176 (866) 311-3268 phone, (480) 926-3598

p0930015, d0930027 Rev 1.0



Environmental Assessment

for

Mobiles

for

FCC ID: PKRNVWE760D

Model: PKRNVWE760D co located with E2K533ANH

to

Federal Communications Commission

47 CFR 1.1310

Radio Frequency Radiation Exposure Limits

Date Of Report: March 31, 2009

On the Behalf of the Applicant:	Novatel Wireless Inc.
At the Request of:	Novatel Wireless Inc. 9645 Scranton Rd, Suite 205 San Diego, CA 92121
Attention of:	John Spall, Project Manager Ph: 858-812-0697 Fax: 858-450-7183 email: jspall@nvtl.com

Hoosamuddin S. Bandukwala, Lab Director

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p0930015, d0930027 Rev 1.0



Revision History

Revision	Date	Revised By	Reason for revision
1.0	March 31, 2009	H Bandukwala	Original Document



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Required information per ISO 17025-2005, paragraph 5.10:

a)	Test Report (Supplemental)
b) Laboratory: (FCC: 31040/SIT) (Canada: IC 2044)	Flom Test Labs 3356 N. San Marcos Place, Suite 107 Chandler, AZ 85225
c) Report Number:	d0930027
d) Client:	Novatel Wireless Inc. 9645 Scranton Rd, Suite 205 San Diego, CA 92121
e) Identification: Description:	PKRNVWE760D co located with E2K533ANH Laptop Computer Studio 1737 - Pacino/Montevina
f) EUT Condition:	Not required unless specified in individual tests.
g) Report Date:	March 31, 2009
h, j, k):	As indicated in individual tests.
i) Sampling method:	No sampling procedure used.
I) Uncertainty:	In accordance with FTL internal quality manual.
m) Supervised by:	

au

Hoosamuddin S. Bandukwala, Lab Director

n) Results:

o) Reproduction:

The results presented in this report relate only to the item tested.

This report must not be reproduced, except in full, without written permission from this laboratory.



Identification of the Equipment Under Test (EUT)

Name and Address of Applicant:	Novatel Wireless Inc. 9645 Scranton Rd, Suite 205 San Diego, CA 92121			
Manufacturer:	Novatel Wireless Inc. 9645 Scranton Rd, Suite 205 San Diego, CA 92121			
FCC ID:	PKRNVWE760D			
Model Number:	Studio 1737 - Pacino/Montevina			
Description:	Class II Permissive			
Type of Emission:	CDMA			
Frequency Range, MHz:	824.7 – 848.31, 1851.25 – 1908.75			
Power Rating, Watts: Switchable	0.877 Variable X_ N/A			
Modulation:	AMPS TDMA X CDMA X OTHER			
Antenna:	Helical Monopole Whip X Other			

Note: For RF Safety test antenna gain taken at the upper range of expected gain (i.e. 0 dBd) and RF Power set to highest nominal power across all channels.



A2LA

"A2LA has accredited Flom Test Labs, Inc. Chandler, AZ for technical competence in the field of Electrical testing. The accreditation covers the specific tests and types of tests listed on the agreed scope of accreditation. This laboratory meets the requirements of ISO 17025:2005 'General Requirements for the Competence of Testing and Calibration Laboratories' and any additional program requirements in the identified field of testing."

Please refer to <u>www.a2la.org</u> for current scope of accreditation.

Certificate number: 2152.01





Standard Test Conditions and Engineering Practices

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-2004 and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst-case measurements.



Name of Test:	Environmental Assessment			
Specification:	FCC: 47 CFR 1.1310			
Measurement Guide:	ANSI/IEEE C95.1 1992			
Name of Test:	R.F. Radiation Exposure			
FCC Rules:	1.1307, 1.1310, 1.1311, 2.1091			
Limits: Uncontrolled Exposure 47 CFR 1.1310 Table 1, (B)	e $0.3-1.234 \text{ MHz}$:Limit $[mW/cm^2] = 100$ $1.34-30 \text{ MHz}$:Limit $[mW/cm^2] = (180/$ $30-300 \text{ MHz}$:Limit $[mW/cm^2] = 0.2$ $300-1500 \text{ MHz}$ Limit $[mW/cm^2] = f/150$ $1500-100,000 \text{ MHz}$:Limit $[mW/cm^2] = 1.0$			
Test Frequencies, MHz Power, Conducted, mW Antenna Gain Antenna Model Distance cm	824 – 848 = 877 = 1.22 dBi Metal Modified Planer Inverted F 20	Antenna		
Limit Calculations	$\text{Limit}_{[mW/cm2]} = 0.549$			
Test Frequencies, MHz Power, Conducted, mW Antenna Gain Antenna Model Distance cm	1851 - 1908 = 628 = 1.63 dBi Metal, Modified Planer Inverted 20	F Antenna		
Limit Calculations	$\text{Limit}_{[mW/cm2]} = 1.0$			



PKRNVWE760D CDMA

CDMA Frequency MHz	TX Power (m)W	Power Density (mW/cm ²)	Limit (mW/cm ²)	Result
824 - 848	877	0.230	0.549	Pass
1851 - 1908	628	0.182	1.0	Pass

E2K533ANH 802.11

802.11 Frequency MHz	TX Power (mW)	Power Density (mW/cm ²)	Limit (mW/cm ²)	Result
2412 - 2462	0.438	0.1742	1.0	Pass
5725 - 5850	0.441	0.1754	1.0	Pass
5180 - 5240	0.044	0.0175	1.0	Pass
5260 - 5320	0.045	0.0179	1.0	Pass
5470 - 5745	0.045	0.0179	1.0	Pass

PKRNVWE760D CDMA Collocated with E2K533ANH 802.11

CDMA Frequency	802.11	CDMA	802.11	Total	Limit	Result
MHz	Frequency	Power	Power	Power	(mW/cm ²)	
	MHz	Density	Density	Density		
		(mW/cm ²)	(mW/cm ²)	(mW/cm ²)		
824 - 848	2412 - 2462	0.230	0.1742	0.404	0.549	Pass
824 - 848	5725 - 5850	0.230	0.1754	0.405	0.549	Pass
824 - 848	5180 - 5240	0.230	0.0175	0.247	0.549	Pass
824 - 848	5260 - 5320	0.230	0.0179	0.247	0.549	Pass
824 - 848	5470 - 5745	0.230	0.0179	0.247	0.549	Pass
1851 - 1908	2412 - 2462	0.182	0.1742	0.356	1.0	Pass
1851 - 1908	5725 - 5850	0.182	0.1754	0.357	1.0	Pass
1851 - 1908	5180 - 5240	0.182	0.0175	0.199	1.0	Pass
1851 - 1908	5260 - 5320	0.182	0.0179	0.199	1.0	Pass
1851 - 1908	5470 - 5745	0.182	0.0179	0.199	1.0	Pass

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Hoosamuddin S. Bandukwala, Lab Director

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Testimonial
and
Statement of Certification

This is to certify that:

- 1. **That** the application was prepared either by, or under the direct supervision of, the undersigned.
- 2. **That** the technical data supplied with the application was taken under my direction and supervision.
- 3. That the data was obtained on representative units, randomly selected.
- 4. **That**, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

Hoosamuddin S. Bandukwala, Lab Director

Supervised By: